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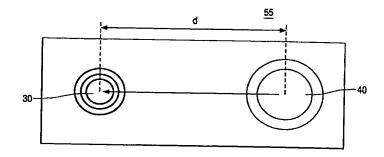
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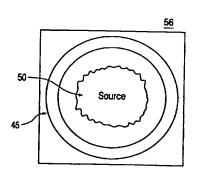
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(54) Title: METHOD OF MEASURING THE PERFORMANCE OF AN ILLUMINATION SYSTEM





(57) Abstract: The performance of an illumination system in, for example, a lithographic projection apparatus can be measured accurately and reliably by means of a test object (55) comprising at least one Fresnel zone lens (30) and an associated reference mark, preferably a ring (40). By superposed imaging of these and detecting and evaluating the composed image (56), telecentricity errors and aberrations of the illumination can be measured.



Declaration under Rule 4.17:

as to applicant's entitlement to apply for and be granted a patent (Rule 4.17(ii)) for the following designations AE, AG, AL, AM, AT, AU, AZ, BA, BB, BG, BR, BW, BY, BZ, CA, CH, CN, CO, CR, CU, CZ, DE, DK, DM, DZ, EC, EE, EG, ES, FI, GB, GD, GE, GH, GM, HR, HU, ID, IL, IN, IS, JP, KE, KG, KP, KR, KZ, LC, LK, LR, LS, LT, LU, LV, MA, MD, MG, MK, MN, MW, MX, MZ, NI, NO, NZ, OM, PG, PH, PL, PT, RO, RU, SC, SD, SE, SG, SK, SL, SY, TJ, TM, TN, TR, TT, TZ, UA, UG, UZ, VC, VN, YU, ZA, ZM, ZW, ARIPO patent (BW, GH, GM, KE, LS, MW, MZ, SD, SL, SZ, TZ, UG, ZM, ZW), Eurasian patent (AM, AZ, BY, KG, KZ, MD, RU, TJ, TM), European patent (AT, BE, BG, CH, CY, CZ, DE, DK, EE, ES, FI, FR, GB, GR, HU, IE, IT,

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A. CLASS	FIFICATION OF SUBJECT MATTER				
IPC 7	G03F7/20 G01M11/02				
	to International Patent Classification (IPC) or to both national classification	fication and IPC			
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	tion searched other than minimum documentation to the extent that				
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EPO-In	ternal, PAJ, WPI Data, INSPEC, IBM-	-TDB	-		
C. DOCUM	ENTS CONSIDERED TO BE RELEVANT	_			
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"A" documer conside	agories of cited documents: It defining the general state of the art which is not red to be of particular relevance coment but published on or after the International te	'T' later document published after the International filing date or priority date and not in conflict with the application but cited to understand the principle or theory underlying the invention 'X' document of particular relevance; the claimed invention			
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